

Notice of References Cited	Application/Control No. 10/590,517		Applicant(s)/Patent Under Reexamination SHIMONO, TAKASHI	
	Examiner MONA M. SANEI		Art Unit 2882	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2008/0247505	10-2008	Patnaik et al.	378/10
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

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